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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	48MHz
Connectivity	I <sup>2</sup> C, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, DMA, I <sup>2</sup> S, LVD, POR, PWM, WDT
Number of I/O	40
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	32K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 18x16b; D/A 1x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	48-UFQFN Exposed Pad
Supplier Device Package	48-QFN (7x7)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mkl17z256vft4">https://www.e-xfl.com/product-detail/nxp-semiconductors/mkl17z256vft4</a>

### Operating Characteristics

- Voltage range: 1.71 to 3.6 V
- Flash write voltage range: 1.71 to 3.6 V
- Temperature range: –40 to 85 °C for WLCSP package and –40 to 105 °C for other packages

### Packages

- 64 LQFP 10mm x 10mm, 0.5mm pitch, 1.6mm thickness
- 64 MAPBGA 5mm x 5mm, 0.5mm pitch, 1.23mm thickness
- 48 QFN 7mm x 7mm, 0.5mm pitch, 0.65mm thickness
- 32 QFN 5mm x 5mm, 0.5mm pitch, 0.65mm thickness
- 36 WLCSP 2.8mm x 2.7mm, 0.4mm pitch, 0.6mm thickness

### Security and Integrity

- 80-bit unique identification number per chip
- Advanced flash security

### I/O

- Up to 54 general-purpose input/output pins (GPIO) and 6 high-drive pad

### Low Power

- Down to 54uA/MHz in very low power run mode
- Down to 1.96uA in VLLS3 mode (RAM + RTC retained)
- Six flexible static modes

## Ordering Information

Product		Memory		Package		IO and ADC channel		
Part number	Marking (Line1/Line2)	Flash (KB)	SRAM (KB)	Pin count	Package	GPIOs	GPIOs (INT/HD) <sup>1</sup>	ADC channels (SE/DP)
MKL17Z128VFM4	M17P7V	128	32	32	QFN	28	19/6	11/2
MKL17Z256VFM4	M17P8V	256	32	32	QFN	28	19/6	11/2
MKL17Z128VFT4	M17P7V	128	32	48	QFN	40	24/6	18/3
MKL17Z256VFT4	M17P8V	256	32	48	QFN	40	24/6	18/3
MKL17Z128VLH4	MKL17Z128V//LH4	128	32	64	LQFP	54	31/6	20/4
MKL17Z256VLH4	MKL17Z256V//LH4	256	32	64	LQFP	54	31/6	20/4
MKL17Z128VMP4	M17P7V	128	32	64	MAPBGA	54	31/6	20/4
MKL17Z256VMP4	M17P8V	256	32	64	MAPBGA	54	31/6	20/4
MKL17Z256CAL4R	MKL17Z256CAL4	256	32	36	WLCSP	26	23/6	7/0

1. INT: interrupt pin numbers; HD: high drive pin numbers

## Related Resources

Type	Description	Resource
Selector Guide	The Freescale Solution Advisor is a web-based tool that features interactive application wizards and a dynamic product selector.	<a href="#">Solution Advisor</a>
Product Brief	The Product Brief contains concise overview/summary information to enable quick evaluation of a device for design suitability.	KL1XPB <sup>1</sup>
Reference Manual	The Reference Manual contains a comprehensive description of the structure and function (operation) of a device.	KL17P64M48SF6RM <sup>1</sup>
Data Sheet	The Data Sheet includes electrical characteristics and signal connections.	This document.
Chip Errata	The chip mask set Errata provides additional or corrective information for a particular device mask set.	KINETIS_L_1N71K <sup>1</sup>

Table continues on the next page...

# 1 Ratings

## 1.1 Thermal handling ratings

Table 1. Thermal handling ratings

Symbol	Description	Min.	Max.	Unit	Notes
T <sub>STG</sub>	Storage temperature	-55	150	°C	1
T <sub>SDR</sub>	Solder temperature, lead-free	—	260	°C	2

1. Determined according to JEDEC Standard JESD22-A103, *High Temperature Storage Life*.
2. Determined according to IPC/JEDEC Standard J-STD-020, *Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices*.

## 1.2 Moisture handling ratings

Table 2. Moisture handling ratings

Symbol	Description	Min.	Max.	Unit	Notes
MSL	Moisture sensitivity level	—	3	—	1

1. Determined according to IPC/JEDEC Standard J-STD-020, *Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices*.

## 1.3 ESD handling ratings

Table 3. ESD handling ratings

Symbol	Description	Min.	Max.	Unit	Notes
V <sub>HBM</sub>	Electrostatic discharge voltage, human body model	-2000	+2000	V	1
V <sub>CDM</sub>	Electrostatic discharge voltage, charged-device model	-500	+500	V	2
I <sub>LAT</sub>	Latch-up current at ambient temperature of 105 °C	-100	+100	mA	3

1. Determined according to JEDEC Standard JESD22-A114, *Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)*.
2. Determined according to JEDEC Standard JESD22-C101, *Field-Induced Charged-Device Model Test Method for Electrostatic-Discharge-Withstand Thresholds of Microelectronic Components*.
3. Determined according to JEDEC Standard JESD78, *IC Latch-Up Test*.

## 1.4 Voltage and current operating ratings

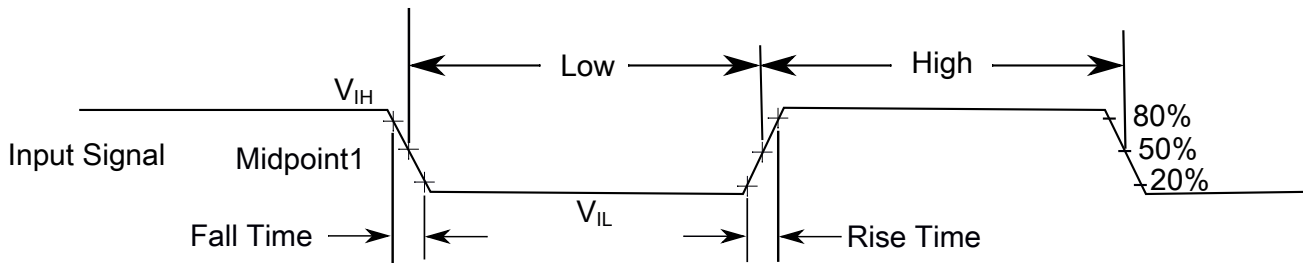
Table 4. Voltage and current operating ratings

Symbol	Description	Min.	Max.	Unit
$V_{DD}$	Digital supply voltage	-0.3	3.8	V
$I_{DD}$	Digital supply current	—	120	mA
$V_{IO}$	IO pin input voltage	-0.3	$V_{DD} + 0.3$	V
$I_D$	Instantaneous maximum current single pin limit (applies to all port pins)	-25	25	mA
$V_{DDA}$	Analog supply voltage	$V_{DD} - 0.3$	$V_{DD} + 0.3$	V

## 2 General

### 2.1 AC electrical characteristics

Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured at the 20% and 80% points, as shown in the following figure.



The midpoint is  $V_{IL} + (V_{IH} - V_{IL}) / 2$

Figure 1. Input signal measurement reference

All digital I/O switching characteristics, unless otherwise specified, assume that the output pins have the following characteristics.

- $C_L=30$  pF loads
- Slew rate disabled
- Normal drive strength

### 2.2 Nonswitching electrical specifications

**Table 8. Power mode transition operating behaviors (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	• VLPS → RUN	—	7.5	8	μs	
	• STOP → RUN	—	7.5	8	μs	

1. Normal boot (FTFA\_FOFT[LPBOOT]=11)

## 2.2.5 Power consumption operating behaviors

The maximum values stated in the following table represent characterized results equivalent to the mean plus three times the standard deviation (mean + 3 sigma).

### NOTE

The while (1) test is executed with flash cache enabled.

### NOTE

The data at 105 °C are for QFN, LQFP and MAPBGA packages only.

**Table 9. Power consumption operating behaviors**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I <sub>DDA</sub>	Analog supply current	—	—	See note	mA	1
I <sub>DD_RUNCO</sub>	Running CoreMark in flash in compute operation mode—48M HIRC mode, 48 MHz core / 24 MHz flash, V <sub>DD</sub> = 3.0 V <ul style="list-style-type: none"> <li>• at 25 °C</li> <li>• at 105 °C</li> </ul>	— —	5.76 6.04	6.40 6.68	mA	2
I <sub>DD_RUNCO</sub>	Running While(1) loop in flash in compute operation mode—48M HIRC mode, 48 MHz core / 24 MHz flash, V <sub>DD</sub> = 3.0 V <ul style="list-style-type: none"> <li>• at 25 °C</li> <li>• at 105 °C</li> </ul>	— —	3.21 3.49	3.85 4.13	mA	
I <sub>DD_RUN</sub>	Run mode current—48M HIRC mode, running CoreMark in Flash all peripheral clock disable 48 MHz core/24 MHz flash, V <sub>DD</sub> = 3.0 V <ul style="list-style-type: none"> <li>• at 25 °C</li> <li>• at 105 °C</li> </ul>	— —	6.45 6.75	7.09 7.39	mA	2
I <sub>DD_RUN</sub>	Run mode current—48M HIRC mode, running CoreMark in flash all peripheral clock disable, 24 MHz core/12 MHz flash, V <sub>DD</sub> = 3.0 V					2

Table continues on the next page...

**Table 9. Power consumption operating behaviors (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes	
	<ul style="list-style-type: none"> <li>at 50 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	10.26	17.62	μA		
		—	33.49	60.19			
		—	102.92	162.20			
I <sub>DD_LLS</sub>	Low-leakage stop mode current, all peripheral disable, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.06	3.33	μA		
		—	4.72	6.85			
		—	8.13	13.30			
		—	13.34	24.70			
		—	41.08	52.43			
I <sub>DD_LLS</sub>	Low-leakage stop mode current with RTC current, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.46	3.73	μA		
		—	5.12	7.25			
		—	8.53	11.78			
		—	13.74	18.91			
		—	41.48	52.83			
I <sub>DD_LLS</sub>	Low-leakage stop mode current with RTC current, at 1.8 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.35	2.70	μA	3	
		—	4.91	6.75			
		—	8.32	11.78			
		—	13.44	18.21			
		—	40.47	51.85			
I <sub>DD_VLLS3</sub>	Very-low-leakage stop mode 3 current, all peripheral disable, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	1.45	1.85	μA		
		—	3.37	4.39			
		—	5.76	8.48			
		—	9.72	14.30			
		—	30.41	37.50			
I <sub>DD_VLLS3</sub>	Very-low-leakage stop mode 3 current with RTC current, at 3.0 V <ul style="list-style-type: none"> <li>at 25 °C and below</li> <li>at 50 °C</li> <li>at 70 °C</li> <li>at 85 °C</li> <li>at 105 °C</li> </ul>	—	2.05	2.45	μA	3	
		—	3.97	4.99			
		—	6.36	9.08			
		—	10.32	14.73			
		—	31.01	38.10			

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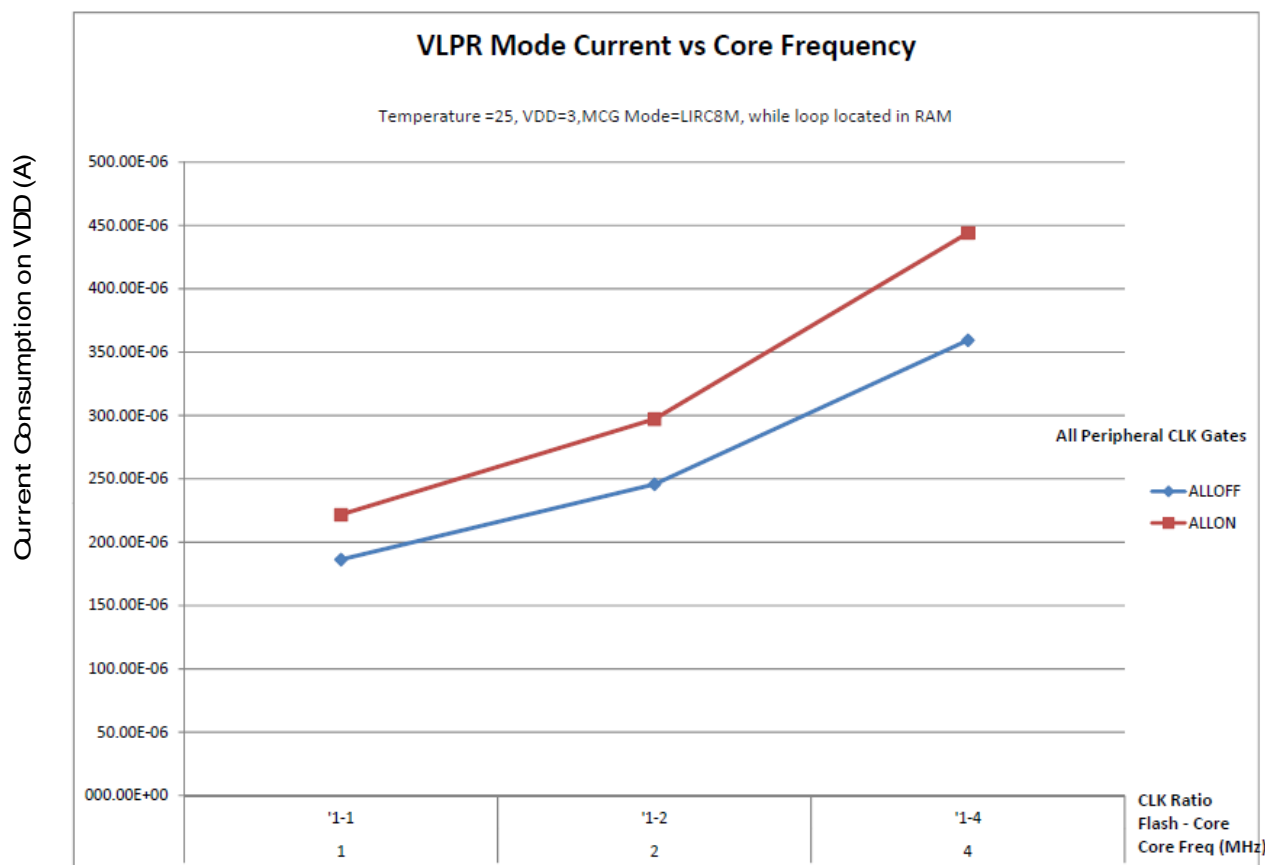


Figure 3. VLPR mode current vs. core frequency

## 2.2.6 EMC radiated emissions operating behaviors

Table 11. EMC radiated emissions operating behaviors for 64-pin LQFP package

Symbol	Description	Frequency band (MHz)	Typ.	Unit	Notes
V <sub>RE1</sub>	Radiated emissions voltage, band 1	0.15–50	11	dBμV	1, 2
V <sub>RE2</sub>	Radiated emissions voltage, band 2	50–150	12	dBμV	
V <sub>RE3</sub>	Radiated emissions voltage, band 3	150–500	10	dBμV	
V <sub>RE4</sub>	Radiated emissions voltage, band 4	500–1000	6	dBμV	
V <sub>RE_IEC</sub>	IEC level	0.15–1000	N	—	2, 3

1. Determined according to IEC Standard 61967-1, *Integrated Circuits - Measurement of Electromagnetic Emissions, 150 kHz to 1 GHz Part 1: General Conditions and Definitions* and IEC Standard 61967-2, *Integrated Circuits - Measurement*

**Table 13. Device clock specifications (continued)**

Symbol	Description	Min.	Max.	Unit
f <sub>LPTMR_ERCLK</sub>	LPTMR external reference clock	—	16	MHz
f <sub>osc_hi_2</sub>	Oscillator crystal or resonator frequency — high frequency mode (high range) (MCG_C2[RANGE]=1x)	—	16	MHz
f <sub>TPM</sub>	TPM asynchronous clock	—	8	MHz
f <sub>LPUART0/1</sub>	LPUART0/1 asynchronous clock	—	8	MHz

1. The maximum value of system clock, core clock, bus clock, and flash clock under normal run mode can be 3% higher than the specified maximum frequency when IRC 48MHz is used as the clock source.
2. The frequency limitations in VLPR and VLPS modes here override any frequency specification listed in the timing specification for any other module. These same frequency limits apply to VLPS, whether VLPS was entered from RUN or from VLPR.
3. The LPTMR can be clocked at this speed in VLPR or VLPS only when the source is an external pin.

## 2.3.2 General switching specifications

These general-purpose specifications apply to all signals configured for GPIO and UART signals.

**Table 14. General switching specifications**

Description	Min.	Max.	Unit	Notes
GPIO pin interrupt pulse width (digital glitch filter disabled) — Synchronous path	1.5	—	Bus clock cycles	1
External RESET and NMI pin interrupt pulse width — Asynchronous path	100	—	ns	2
GPIO pin interrupt pulse width — Asynchronous path	16	—	ns	2
Port rise and fall time	—	36	ns	3

1. The synchronous and asynchronous timing must be met.
2. This is the shortest pulse that is guaranteed to be recognized.
3. 75 pF load

## 2.4 Thermal specifications

### 2.4.1 Thermal operating requirements

**Table 15. Thermal operating requirements for WLCSP package**

Symbol	Description	Min.	Max.	Unit	Notes
T <sub>J</sub>	Die junction temperature	−40	95	°C	
T <sub>A</sub>	Ambient temperature	−40	85	°C	1



- Maximum  $T_A$  can be exceeded only if the user ensures that  $T_J$  does not exceed the maximum. The simplest method to determine  $T_J$  is:  $T_J = T_A + R_{\theta JA} \times \text{chip power dissipation}$ .

**Table 16. Thermal operating requirements for other packages**

Symbol	Description	Min.	Max.	Unit	Notes
$T_J$	Die junction temperature	-40	125	°C	
$T_A$	Ambient temperature	-40	105	°C	1

- Maximum  $T_A$  can be exceeded only if the user ensures that  $T_J$  does not exceed the maximum. The simplest method to determine  $T_J$  is:  $T_J = T_A + R_{\theta JA} \times \text{chip power dissipation}$ .

## 2.4.2 Thermal attributes

**Table 17. Thermal attributes**

Board type	Symbol	Description	48 QFN	32 QFN	64 LQFP	64 MAPB GA	36 WLCS P	Unit	Notes
Single-layer (1S)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	86	101	70	50.3	77.6	°C/W	1
Four-layer (2s2p)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	29	33	51	42.9	38.9	°C/W	
Single-layer (1S)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	71	84	58	41.4	69.6	°C/W	
Four-layer (2s2p)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	24	28	45	38.0	35.6	°C/W	
—	$R_{\theta JB}$	Thermal resistance, junction to board	12	13	33	39.6	34.8	°C/W	2
—	$R_{\theta JC}$	Thermal resistance, junction to case	1.7	1.7	20	27.3	0.37	°C/W	3
—	$\Psi_{JT}$	Thermal characterization parameter, junction to package top outside center (natural convection)	2	3	4	0.4	0.2	°C/W	4
—	$\Psi_{JB}$	Thermal characterization parameter, junction to package bottom (natural convection)	-	-	-	12.6	-	°C/W	5

- Determined according to JEDEC Standard JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions—Natural Convection (Still Air)*, or EIA/JEDEC Standard JESD51-6, *Integrated Circuit Thermal Test Method Environmental Conditions—Forced Convection (Moving Air)*.
- Determined according to JEDEC Standard JESD51-8, *Integrated Circuit Thermal Test Method Environmental Conditions—Junction-to-Board*.

**Table 21. Oscillator DC electrical specifications (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	<ul style="list-style-type: none"> <li>• 24 MHz</li> <li>• 32 MHz</li> </ul>	—	1.5	—	mA	
$I_{DDOSC}$	Supply current — high gain mode (HGO=1) <ul style="list-style-type: none"> <li>• 32 kHz</li> <li>• 4 MHz</li> <li>• 8 MHz (RANGE=01)</li> <li>• 16 MHz</li> <li>• 24 MHz</li> <li>• 32 MHz</li> </ul>	—	25	—	$\mu$ A	1
		—	400	—	$\mu$ A	
		—	500	—	$\mu$ A	
		—	2.5	—	mA	
		—	3	—	mA	
		—	4	—	mA	
$C_x$	EXTAL load capacitance	—	—	—		2, 3
$C_y$	XTAL load capacitance	—	—	—		2, 3
$R_F$	Feedback resistor — low-frequency, low-power mode (HGO=0)	—	—	—	M $\Omega$	2, 4
	Feedback resistor — low-frequency, high-gain mode (HGO=1)	—	10	—	M $\Omega$	
	Feedback resistor — high-frequency, low-power mode (HGO=0)	—	—	—	M $\Omega$	
	Feedback resistor — high-frequency, high-gain mode (HGO=1)	—	1	—	M $\Omega$	
$R_S$	Series resistor — low-frequency, low-power mode (HGO=0)	—	—	—	k $\Omega$	
	Series resistor — low-frequency, high-gain mode (HGO=1)	—	200	—	k $\Omega$	
	Series resistor — high-frequency, low-power mode (HGO=0)	—	—	—	k $\Omega$	
	Series resistor — high-frequency, high-gain mode (HGO=1)	—	0	—	k $\Omega$	
$V_{pp}^5$	Peak-to-peak amplitude of oscillation (oscillator mode) — low-frequency, low-power mode (HGO=0)	—	0.6	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — low-frequency, high-gain mode (HGO=1)	—	$V_{DD}$	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — high-frequency, low-power mode (HGO=0)	—	0.6	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — high-frequency, high-gain mode (HGO=1)	—	$V_{DD}$	—	V	

1.  $V_{DD}=3.3$  V, Temperature =25 °C

2. See crystal or resonator manufacturer's recommendation

### 3.4.1.1 Flash timing specifications — program and erase

The following specifications represent the amount of time the internal charge pumps are active and do not include command overhead.

**Table 23. NVM program/erase timing specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$t_{hvp\text{gm}4}$	Longword Program high-voltage time	—	7.5	18	$\mu\text{s}$	—
$t_{h\text{versscr}}$	Sector Erase high-voltage time	—	13	113	ms	1
$t_{h\text{versblk}128\text{k}}$	Erase Block high-voltage time for 128 KB	—	52	452	ms	1

1. Maximum time based on expectations at cycling end-of-life.

### 3.4.1.2 Flash timing specifications — commands

**Table 24. Flash command timing specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$t_{rd1\text{blk}128\text{k}}$	Read 1s Block execution time • 128 KB program flash	—	—	1.7	ms	1
$t_{rd1\text{sec}1\text{k}}$	Read 1s Section execution time (flash sector)	—	—	60	$\mu\text{s}$	1
$t_{pgm\text{chk}}$	Program Check execution time	—	—	45	$\mu\text{s}$	1
$t_{rd\text{rsrc}}$	Read Resource execution time	—	—	30	$\mu\text{s}$	1
$t_{pgm4}$	Program Longword execution time	—	65	145	$\mu\text{s}$	—
$t_{ers\text{blk}128\text{k}}$	Erase Flash Block execution time • 128 KB program flash	—	88	600	ms	2
$t_{ers\text{scr}}$	Erase Flash Sector execution time	—	14	114	ms	2
$t_{rd1\text{all}}$	Read 1s All Blocks execution time	—	—	1.8	ms	1
$t_{rd\text{once}}$	Read Once execution time	—	—	25	$\mu\text{s}$	1
$t_{pgm\text{once}}$	Program Once execution time	—	65	—	$\mu\text{s}$	—
$t_{ers\text{all}}$	Erase All Blocks execution time	—	175	1300	ms	2
$t_{\text{vfykey}}$	Verify Backdoor Access Key execution time	—	—	30	$\mu\text{s}$	1
$t_{ers\text{allu}}$	Erase All Blocks Unsecure execution time	—	175	1300	ms	2

1. Assumes 25 MHz flash clock frequency.

2. Maximum times for erase parameters based on expectations at cycling end-of-life.

**Table 28. 16-bit ADC characteristics ( $V_{REFH} = V_{DDA}$ ,  $V_{REFL} = V_{SSA}$ ) (continued)**

Symbol	Description	Conditions <sup>1</sup>	Min.	Typ. <sup>2</sup>	Max.	Unit	Notes
		<ul style="list-style-type: none"> <li>&lt;12-bit modes</li> </ul>	—	±0.5	-0.7 to +0.5		
$E_{FS}$	Full-scale error	<ul style="list-style-type: none"> <li>12-bit modes</li> <li>&lt;12-bit modes</li> </ul>	—	-4	-5.4	LSB <sup>4</sup>	$V_{ADIN} = V_{DDA}$ <sup>5</sup>
$E_Q$	Quantization error	<ul style="list-style-type: none"> <li>16-bit modes</li> <li>≤13-bit modes</li> </ul>	—	-1 to 0	—	LSB <sup>4</sup>	
ENOB	Effective number of bits	16-bit differential mode					6
		<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	12.8	14.5	—	bits	
		<ul style="list-style-type: none"> <li>Avg = 4</li> </ul>	11.9	13.8	—	bits	
		16-bit single-ended mode					
<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	12.2	13.9	—	bits			
<ul style="list-style-type: none"> <li>Avg = 4</li> </ul>	11.4	13.1	—	bits			
SINAD	Signal-to-noise plus distortion	See ENOB	6.02 × ENOB + 1.76			dB	
THD	Total harmonic distortion	16-bit differential mode				dB	7
		<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	—	-94	—	dB	
		16-bit single-ended mode				dB	
		<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	—	-85	—		
SFDR	Spurious free dynamic range	16-bit differential mode				dB	7
		<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	82	95	—	dB	
		16-bit single-ended mode				dB	
		<ul style="list-style-type: none"> <li>Avg = 32</li> </ul>	78	90			
$E_{IL}$	Input leakage error		$I_{in} \times R_{AS}$			mV	$I_{in}$ = leakage current (refer to the MCU's voltage and current operating ratings)
	Temp sensor slope	Across the full temperature range of the device	1.55	1.62	1.69	mV/°C	8
$V_{TEMP25}$	Temp sensor voltage	25 °C	706	716	726	mV	8

1. All accuracy numbers assume the ADC is calibrated with  $V_{REFH} = V_{DDA}$

2. Typical values assume  $V_{DDA} = 3.0$  V, Temp = 25 °C,  $f_{ADCK} = 2.0$  MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

### 3.6.2 Voltage reference electrical specifications

**Table 29. VREF full-range operating requirements**

Symbol	Description	Min.	Max.	Unit	Notes
$V_{DDA}$	Supply voltage		3.6	V	
$T_A$	Temperature	Operating temperature range of the device		°C	
$C_L$	Output load capacitance	100		nF	1, 2

1.  $C_L$  must be connected to VREF\_OUT if the VREF\_OUT functionality is being used for either an internal or external reference.
2. The load capacitance should not exceed +/-25% of the nominal specified  $C_L$  value over the operating temperature range of the device.

Table 30 is tested under the condition of setting VREF\_TRM[CHOPEN], VREF\_SC[REGEN] and VREF\_SC[ICOMPEN] bits to 1.

**Table 30. VREF full-range operating behaviors**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$V_{out}$	Voltage reference output with factory trim at nominal $V_{DDA}$ and temperature=25C	1.1915	1.195	1.1977	V	1
$V_{out}$	Voltage reference output — factory trim	1.1584	—	1.2376	V	1
$V_{out}$	Voltage reference output — user trim	1.193	—	1.197	V	1
$V_{step}$	Voltage reference trim step	—	0.5	—	mV	1
$V_{tdrift}$	Temperature drift ( $V_{max}$ - $V_{min}$ across the full temperature range: 0 to 70°C)	—	—	50	mV	1
$I_{bg}$	Bandgap only current	—	—	80	μA	1
$I_{lp}$	Low-power buffer current	—	—	360	μA	1
$I_{hp}$	High-power buffer current	—	—	1	mA	1
$\Delta V_{LOAD}$	Load regulation • current = ± 1.0 mA	—	200	—	μV	1, 2
$T_{stup}$	Buffer startup time	—	—	100	μs	
$T_{chop\_osc\_st\ up}$	Internal bandgap start-up delay with chop oscillator enabled	—	—	35	ms	—
$V_{vdrift}$	Voltage drift ( $V_{max}$ - $V_{min}$ across the full voltage range)	—	2	—	mV	1

1. See the chip's Reference Manual for the appropriate settings of the VREF Status and Control register.
2. Load regulation voltage is the difference between the VREF\_OUT voltage with no load vs. voltage with defined load

**Table 31. VREF limited-range operating requirements**

Symbol	Description	Min.	Max.	Unit	Notes
$T_A$	Temperature	0	50	°C	

**Table 32. VREF limited-range operating behaviors**

Symbol	Description	Min.	Max.	Unit	Notes
$V_{out}$	Voltage reference output with factory trim	1.173	1.225	V	

### 3.6.3 CMP and 6-bit DAC electrical specifications

**Table 33. Comparator and 6-bit DAC electrical specifications**

Symbol	Description	Min.	Typ.	Max.	Unit
$V_{DD}$	Supply voltage	1.71	—	3.6	V
$I_{DDHS}$	Supply current, High-speed mode (EN=1, PMODE=1)	—	—	200	μA
$I_{DDL S}$	Supply current, low-speed mode (EN=1, PMODE=0)	—	—	20	μA
$V_{AIN}$	Analog input voltage	$V_{SS} - 0.3$	—	$V_{DD}$	V
$V_{AIO}$	Analog input offset voltage	—	—	20	mV
$V_H$	Analog comparator hysteresis <sup>1</sup> <ul style="list-style-type: none"> <li>• CR0[HYSTCTR] = 00</li> <li>• CR0[HYSTCTR] = 01</li> <li>• CR0[HYSTCTR] = 10</li> <li>• CR0[HYSTCTR] = 11</li> </ul>	—	5 10 20 30	—	mV mV mV mV
$V_{CMPOH}$	Output high	$V_{DD} - 0.5$	—	—	V
$V_{CMPOI}$	Output low	—	—	0.5	V
$t_{DHS}$	Propagation delay, high-speed mode (EN=1, PMODE=1)	20	50	200	ns
$t_{DLS}$	Propagation delay, low-speed mode (EN=1, PMODE=0)	80	250	600	ns
	Analog comparator initialization delay <sup>2</sup>	—	—	40	μs
$I_{DAC6b}$	6-bit DAC current adder (enabled)	—	7	—	μA
INL	6-bit DAC integral non-linearity	-0.5	—	0.5	LSB <sup>3</sup>
DNL	6-bit DAC differential non-linearity	-0.3	—	0.3	LSB

1. Typical hysteresis is measured with input voltage range limited to 0.6 to  $V_{DD}-0.6$  V.
2. Comparator initialization delay is defined as the time between software writes to change control inputs (Writes to CMP\_DACCR[DACEN], CMP\_DACCR[VRSEL], CMP\_DACCR[VOSEL], CMP\_MUXCR[PSEL], and CMP\_MUXCR[MSEL]) and the comparator output settling to a stable level.
3. 1 LSB =  $V_{reference}/64$

### 3.8.1 SPI switching specifications

The Serial Peripheral Interface (SPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic SPI timing modes. See the SPI chapter of the chip's Reference Manual for information about the modified transfer formats used for communicating with slower peripheral devices.

All timing is shown with respect to 20%  $V_{DD}$  and 80%  $V_{DD}$  thresholds, unless noted, as well as input signal transitions of 3 ns and a 30 pF maximum load on all SPI pins.

**Table 36. SPI master mode timing on slew rate disabled pads**

Num.	Symbol	Description	Min.	Max.	Unit	Note
1	$f_{op}$	Frequency of operation	$f_{periph}/2048$	$f_{periph}/2$	Hz	1
2	$t_{SPSCK}$	SPSCK period	$2 \times t_{periph}$	$2048 \times t_{periph}$	ns	2
3	$t_{Lead}$	Enable lead time	1/2	—	$t_{SPSCK}$	—
4	$t_{Lag}$	Enable lag time	1/2	—	$t_{SPSCK}$	—
5	$t_{WSPSCK}$	Clock (SPSCK) high or low time	$t_{periph} - 30$	$1024 \times t_{periph}$	ns	—
6	$t_{SU}$	Data setup time (inputs)	18	—	ns	—
7	$t_{HI}$	Data hold time (inputs)	0	—	ns	—
8	$t_v$	Data valid (after SPSCK edge)	—	15	ns	—
9	$t_{HO}$	Data hold time (outputs)	0	—	ns	—
10	$t_{RI}$	Rise time input	—	$t_{periph} - 25$	ns	—
	$t_{FI}$	Fall time input				
11	$t_{RO}$	Rise time output	—	25	ns	—
	$t_{FO}$	Fall time output				

1. For SPI0  $f_{periph}$  is the bus clock ( $f_{BUS}$ ). For SPI1  $f_{periph}$  is the system clock ( $f_{SYS}$ ).
2.  $t_{periph} = 1/f_{periph}$

**Table 37. SPI master mode timing on slew rate enabled pads**

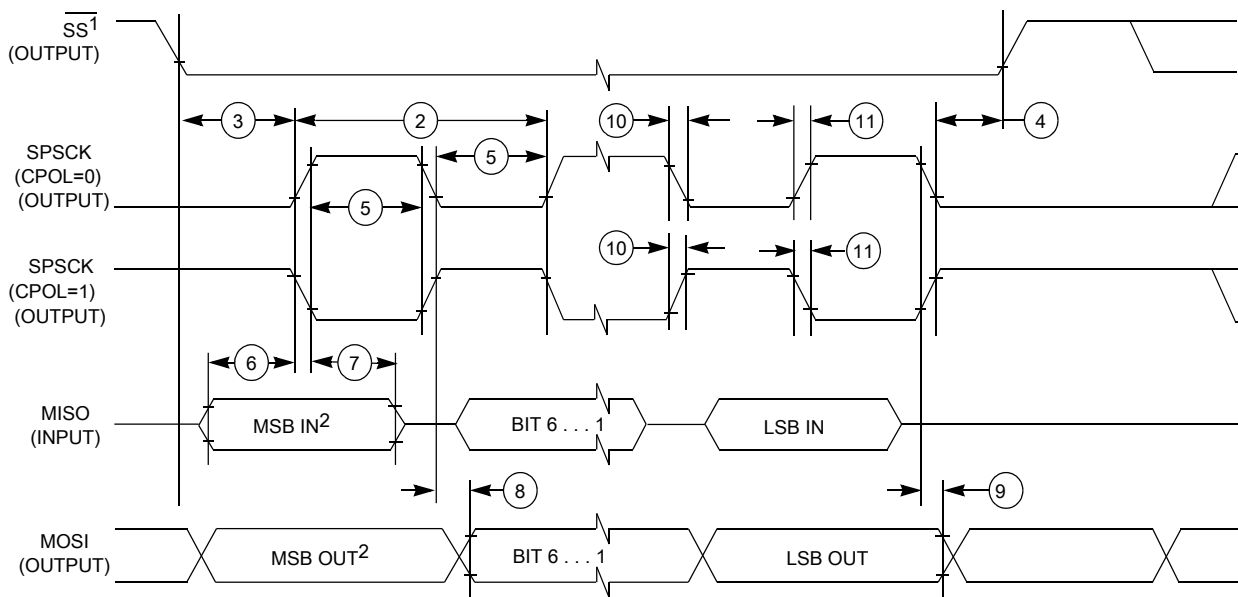
Num.	Symbol	Description	Min.	Max.	Unit	Note
1	$f_{op}$	Frequency of operation	$f_{periph}/2048$	$f_{periph}/2$	Hz	1
2	$t_{SPSCK}$	SPSCK period	$2 \times t_{periph}$	$2048 \times t_{periph}$	ns	2
3	$t_{Lead}$	Enable lead time	1/2	—	$t_{SPSCK}$	—
4	$t_{Lag}$	Enable lag time	1/2	—	$t_{SPSCK}$	—
5	$t_{WSPSCK}$	Clock (SPSCK) high or low time	$t_{periph} - 30$	$1024 \times t_{periph}$	ns	—
6	$t_{SU}$	Data setup time (inputs)	96	—	ns	—
7	$t_{HI}$	Data hold time (inputs)	0	—	ns	—

*Table continues on the next page...*

**Table 37. SPI master mode timing on slew rate enabled pads (continued)**

Num.	Symbol	Description	Min.	Max.	Unit	Note
8	$t_v$	Data valid (after SPSCCK edge)	—	52	ns	—
9	$t_{HO}$	Data hold time (outputs)	0	—	ns	—
10	$t_{RI}$	Rise time input	—	$t_{periph} - 25$	ns	—
	$t_{FI}$	Fall time input				
11	$t_{RO}$	Rise time output	—	36	ns	—
	$t_{FO}$	Fall time output				

1. For SPI0  $f_{periph}$  is the bus clock ( $f_{BUS}$ ). For SPI1  $f_{periph}$  is the system clock ( $f_{SYS}$ ).
2.  $t_{periph} = 1/f_{periph}$



1. If configured as an output.
2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

**Figure 14. SPI master mode timing (CPHA = 0)**



64 MAP BGA	64 LQFP	48 QFN	36 WLC SP	32 QFN	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
F4	13	9	E6	7	VDDA	VDDA	VDDA							
G4	14	10	E6	—	VREFH	VREFH	VREFH							
G3	15	11	F6	—	VREFL	VREFL	VREFL							
F3	16	12	F6	8	VSSA	VSSA	VSSA							
H1	17	13	—	—	PTE29	CMP0_IN5/ ADC0_SE4b	CMP0_IN5/ ADC0_SE4b	PTE29		TPM0_CH2	TPM_ CLKIN0			
H2	18	14	E5	9	PTE30	DAC0_OUT/ ADC0_ SE23/ CMP0_IN4	DAC0_OUT/ ADC0_ SE23/ CMP0_IN4	PTE30		TPM0_CH3	TPM_ CLKIN1	LPUART1_ TX	LPTMR0_ ALT1	
H3	19	—	—	—	PTE31	DISABLED		PTE31		TPM0_CH4				
H4	20	15	—	—	PTE24	DISABLED		PTE24		TPM0_CH0		I2C0_SCL		
H5	21	16	—	—	PTE25	DISABLED		PTE25		TPM0_CH1		I2C0_SDA		
D3	22	17	F5	10	PTA0	SWD_CLK		PTA0		TPM0_CH5				SWD_CLK
D4	23	18	E4	11	PTA1	DISABLED		PTA1	LPUART0_ RX	TPM2_CH0				
E5	24	19	D4	12	PTA2	DISABLED		PTA2	LPUART0_ TX	TPM2_CH1				
D5	25	20	F4	13	PTA3	SWD_DIO		PTA3	I2C1_SCL	TPM0_CH0				SWD_DIO
G5	26	21	F3	14	PTA4	NMI_b		PTA4	I2C1_SDA	TPM0_CH1				NMI_b
F5	27	—	—	—	PTA5	DISABLED		PTA5		TPM0_CH2			I2S0_TX_ BCLK	
H6	28	—	—	—	PTA12	DISABLED		PTA12		TPM1_CH0			I2S0_TXD0	
G6	29	—	—	—	PTA13	DISABLED		PTA13		TPM1_CH1			I2S0_TX_ FS	
—	—	—	E3	—	PTA14	DISABLED		PTA14	SPI0_PCS0	LPUART0_ TX			I2S0_RX_ BCLK	I2S0_TXD0
—	—	—	D3	—	PTA15	DISABLED		PTA15	SPI0_SCK	LPUART0_ RX			I2S0_RXD0	
—	—	—	C3	—	PTA16	DISABLED		PTA16	SPI0_MOSI			SPI0_MISO	I2S0_RX_ FS	I2S0_RXD0
—	—	—	D2	—	PTA17	DISABLED		PTA17	SPI0_MISO			SPI0_MOSI	I2S0_MCLK	
G7	30	22	E2	15	VDD	VDD	VDD							
H7	31	23	F2	16	VSS	VSS	VSS							
H8	32	24	F1	17	PTA18	EXTAL0	EXTAL0	PTA18		LPUART1_ RX	TPM_ CLKIN0			
G8	33	25	E1	18	PTA19	XTAL0	XTAL0	PTA19		LPUART1_ TX	TPM_ CLKIN1		LPTMR0_ ALT1	
F8	34	26	D1	19	PTA20	RESET_b		PTA20						RESET_b
F7	35	27	C2	20	PTB0/ LLWU_P5	ADC0_SE8	ADC0_SE8	PTB0/ LLWU_P5	I2C0_SCL	TPM1_CH0				
F6	36	28	C1	21	PTB1	ADC0_SE9	ADC0_SE9	PTB1	I2C0_SDA	TPM1_CH1				
E7	37	29	—	—	PTB2	ADC0_SE12	ADC0_SE12	PTB2	I2C0_SCL	TPM2_CH0				

64 MAP BGA	64 LQFP	48 QFN	36 WLC SP	32 QFN	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
A2	64	48	B6	32	PTD7	DISABLED		PTD7	SPI1_MISO	LPUART0_TX		SPI1_MOSI	FXIO0_D7	
C5	—	—	C5	—	Reserved	Reserved	Reserved							
—	—	—	C6	—	Reserved	Reserved	Reserved							
—	—	—	D5	—	Reserved	Reserved	Reserved							
—	—	—	D6	—	Reserved	Reserved	Reserved							

## 5.2 KL17 Family Pinouts

Figure below shows the 32 QFN pinouts:

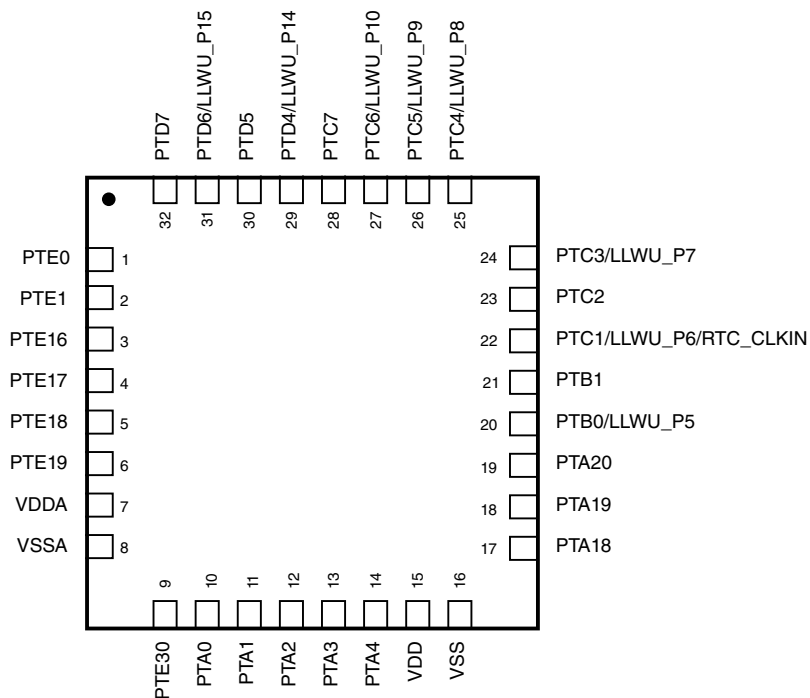


Figure 23. 32 QFN Pinout diagram

Figure below shows the 36 WLCSP pinouts:

## Pinouts and Packaging

	1	2	3	4	5	6	
A	PTC3	PTC4	PTC5	PTC7	PTD4	PTD6	A
B	PTC1	PTC2	VDD	PTC6	PTD5	PTD7	B
C	PTB1	PTB0	PTA16	VSS	Reserved	Reserved	C
D	PTA20	PTA17	PTA15	PTA2	Reserved	Reserved	D
E	PTA19	VDD	PTA14	PTA1	PTE30	VDDA/ VREFH	E
F	PTA18	VSS	PTA4	PTA3	PTA0	VSSA/ VREFL	F
	1	2	3	4	5	6	

**Figure 24. 36 WLCSP Pinout diagram**

Figure below shows the 48 QFN pinouts:

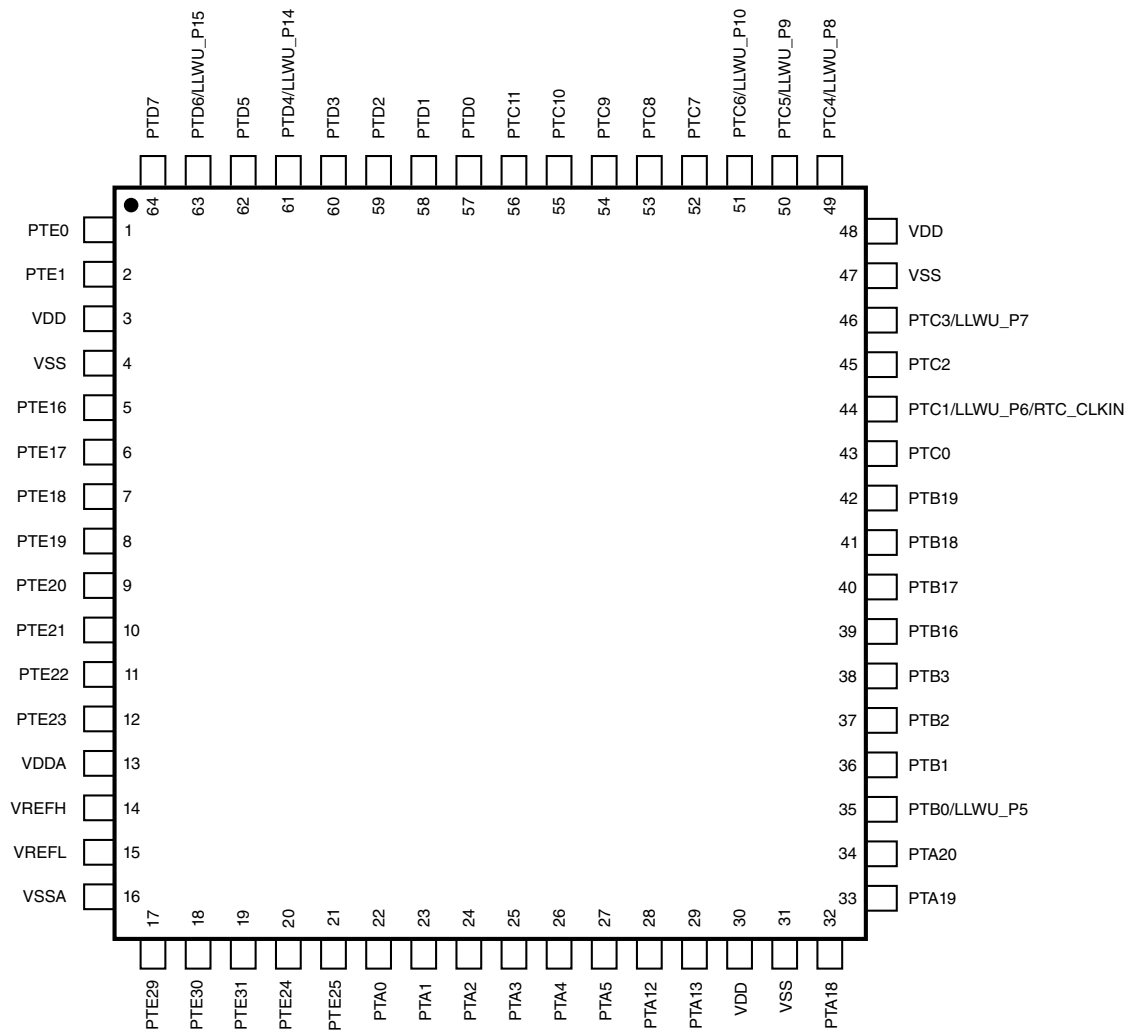


Figure 27. 64 LQFP Pinout diagram

### 5.3 Recommended connection for unused analog and digital pins

Table 46 shows the recommended connections for analog interface pins if those analog interfaces are not used in the customer's application

## 8.2 Examples

*Operating rating:*

Symbol	Description	Min.	Max.	Unit
V <sub>DD</sub>	1.0 V core supply voltage	-0.3	1.2	V

*Operating requirement:*

Symbol	Description	Min.	Max.	Unit
V <sub>DD</sub>	1.0 V core supply voltage	0.9	1.1	V

*Operating behavior that includes a typical value:*

Symbol	Description	Min.	Typ.	Max.	Unit
I <sub>WP</sub>	Digital I/O weak pullup/pulldown current	10	70	130	μA

## 8.3 Typical-value conditions

Typical values assume you meet the following conditions (or other conditions as specified):

Symbol	Description	Value	Unit
T <sub>A</sub>	Ambient temperature	25	°C
V <sub>DD</sub>	Supply voltage	3.3	V